

TECHNICAL SPECIFICATION



**Radio frequency connectors –
Part 1-51: Technical specification of electrical tests – Uncertainty specification
of frequency domain test for return loss**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

RADIO FREQUENCY CONNECTORS –

**Part 1-51: Technical specification of electrical tests –
Uncertainty specification of frequency domain test for return loss**

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- the required support cannot be obtained for the publication of an International Standard, despite repeated efforts, or
- the subject is still under technical development or where, for any other reason, there is the future but no immediate possibility of an agreement on an International Standard.

Technical Specifications are subject to review within three years of publication to decide whether they can be transformed into International Standards.

IEC TS 61169-1-51, which is a Technical Specification, has been prepared by subcommittee 46F: RF and microwave passive components, of IEC technical committee 46: Cables, wires, waveguides, RF connectors, RF and microwave passive components and accessories.

The text of this Technical Specification is based on the following documents:

Draft TS	Report on voting
46F/488/DTS	46F/495/RVDTS

Full information on the voting for the approval of this Technical Specification can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61169 series, published under the general title *Radio frequency connectors*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

This document relates to technical requirements for electrical tests for radio frequency connectors. In IEC 61169-1:2013, a frequency domain test method has been described. However, the document does not contain the quantitative uncertainty specification for measurement instruments, i.e. vector network analysers and terminations, for return loss. This document shows quantitative uncertainty specifications of electrical tests for return loss of radio frequency connectors. In addition, the document includes a brief analysis of vector network analyser measurement uncertainty for return loss measurements of radio frequency connectors.

RADIO FREQUENCY CONNECTORS –

Part 1-51: Technical specification of electrical tests – Uncertainty specification of frequency domain test for return loss

1 Scope

This part of IEC 61169, which is a Technical Specification, relates to radio frequency connectors for RF transmission lines for use in telecommunications, electronics and similar equipment.

It provides the technical report for the uncertainty specifications for return loss measurements, which apply to individual connector types, by vector network analysers (VNAs). It is intended to establish concepts and procedures considering:

- testing and measuring procedures concerning frequency domain electrical properties;
- uncertainty specifications of VNAs measurements for return loss of RF connectors.

The test methods and procedures of this document are intended for acceptance and type approval testing.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60027, *Letter symbols to be used in electrical technology*

IEC 60050, *International Electrotechnical Vocabulary*
(available from: <http://www.electropedia.org>)

IEC 60617, *Graphical symbols for diagrams*

IEC 61169-1:2013, *Radio frequency connectors – Part 1: Generic specification – General requirements and measuring methods*

ISO/IEC 17025:2017, *General requirements for the competence of testing and calibration laboratories*

ISO/IEC Guide 98-1, *Uncertainty of measurement – Part 1: Introduction to the expression of uncertainty in measurement*

ISO 1000:1992¹, *SI units and recommendations for the use of their multiples and of certain other units*

¹ Withdrawn in 2009, revised by ISO 80000-1:2009.